

Product data sheet

1. General description

NPN/NPN Resistor-Equipped Transistors (RET) in a leadless ultra small DFN1010B-6 (SOT1216) Surface-Mounted Device (SMD) plastic package.

2. Features and benefits

- 100 mA output current capability
- Built-in bias resistors
- Simplifies circuit design
- Low package height of 0.37 mm
- Reduces component count
- Reduces pick and place costs
- AEC-Q101 qualified

3. Applications

- Low current peripheral driver
- Control of IC inputs
- Replaces general-purpose transistors in digital applications
- Mobile applications

4. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per transist	or	'		1			
V _{CEO}	collector-emitter voltage	open base		-	-	50	V
lo	output current			-	-	100	mA
Per transist	or						
R1	bias resistor 1	T _{amb} = 25 °C	[1]	7	10	13	kΩ
R2/R1	bias resistor ratio		[1]	3.7	4.7	5.7	

[1] See section "Test information" for resistor calculation and test conditions.





5. Pinning information

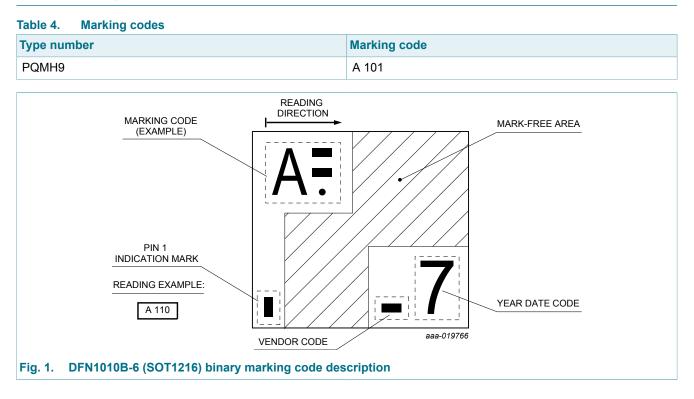
Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	GND1	GND (emitter) TR1		O1 I2 GND2
2	11	input (base) TR1		
3	02	output (collector) TR2	2 5	
4	GND2	GND (emitter) TR2		
5	12	input (base) TR2		
6	01	output (collector) TR1	Transparent top view	
7	01	output (collector) TR1	DFN1010B-6 (SOT1216)	GND1 I1 O2 aaa-019894
8	02	output (collector) TR2		

6. Ordering information

Table 3. Ordering information					
Type number	Package				
	Name	Description	Version		
PQMH9	DFN1010B-6	DFN1010B-6: plastic thermal enhanced ultra thin small outline package; no leads; 6 terminals	SOT1216		

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7. Marking



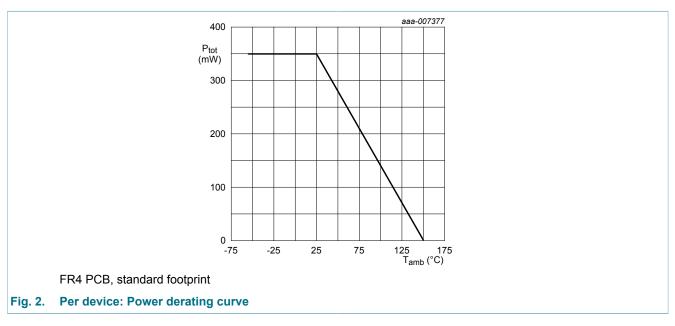
8. Limiting values

Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
Per transis	tor					
V _{CBO}	collector-base voltage	open emitter		-	50	V
V _{CEO}	collector-emitter voltage	open base		-	50	V
V _{EBO}	emitter-base voltage	open collector		-	6	V
VI	input voltage	positive		-	40	V
		negative		-	-6	V
I _O	output current			-	100	mA
I _{CM}	peak collector current	$t_p \le 1$ ms; single pulse		-	100	mA
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[1]	-	230	mW
Per device		L.	I		1	
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[1]	-	350	mW
Tj	junction temperature			-	150	°C
T _{amb}	ambient temperature			-55	150	°C
T _{stg}	storage temperature			-65	150	°C

^[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

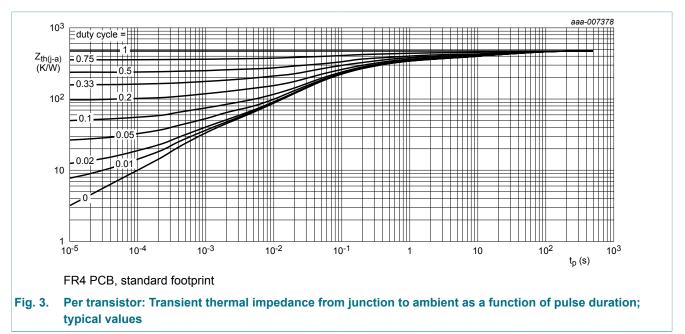


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9. Thermal characteristics

Table 6. The	rmal characteristics						
Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
Per transistor	Per transistor						
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	[1]	-	-	543	K/W
Per device							
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	[1]	-	-	357	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.



10. Characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per transis	tor						
I _{CBO}	collector-base cut-off current (emitter open)	V_{CB} = 50 V; I _E = 0 A; T _{amb} = 25 °C		-	-	100	nA
I _{CEO}	collector-emitter cut-off	V_{CE} = 30 V; I _B = 0 A; T _{amb} = 25 °C		-	-	1	μA
	current (base open)	V_{CE} = 30 V; I _B = 0 A; T _{amb} = 150 °C		-	-	5	μA
I _{EBO}	emitter-base cut-off current (collector open)	V_{EB} = 5 V; I _C = 0 A; T _{amb} = 25 °C		-	-	150	μA
h _{FE}	DC current gain	V _{CE} = 5 V; I _C = 5 mA; T _{amb} = 25 °C		100	-	-	
V _{CEsat}	collector-emitter saturation voltage	I_{C} = 5 mA; I_{B} = 0.25 mA; T_{amb} = 25 °C		-	-	100	mV
V _{I(off)}	off-state input voltage	V_{CE} = 5 V; I _C = 100 µA; T _{amb} = 25 °C		-	0.7	0.5	V
V _{I(on)}	on-state input voltage	V_{CE} = 0.3 V; I _C = 10 mA; T _{amb} = 25 °C		1.4	0.8	-	V
R1	bias resistor 1	T _{amb} = 25 °C	[1]	7	10	13	kΩ
R2/R1	bias resistor ratio		[1]	3.7	4.7	5.7	
C _C	collector capacitance	V_{CB} = 10 V; I _E = 0 A; f = 1 MHz; T _{amb} = 25 °C		-	-	2.5	pF
f _T	transition frequency	V _{CE} = 5 V; I _C = 10 mA; f = 100 MHz; T _{amb} = 25 °C	[2]	-	230	-	MHz

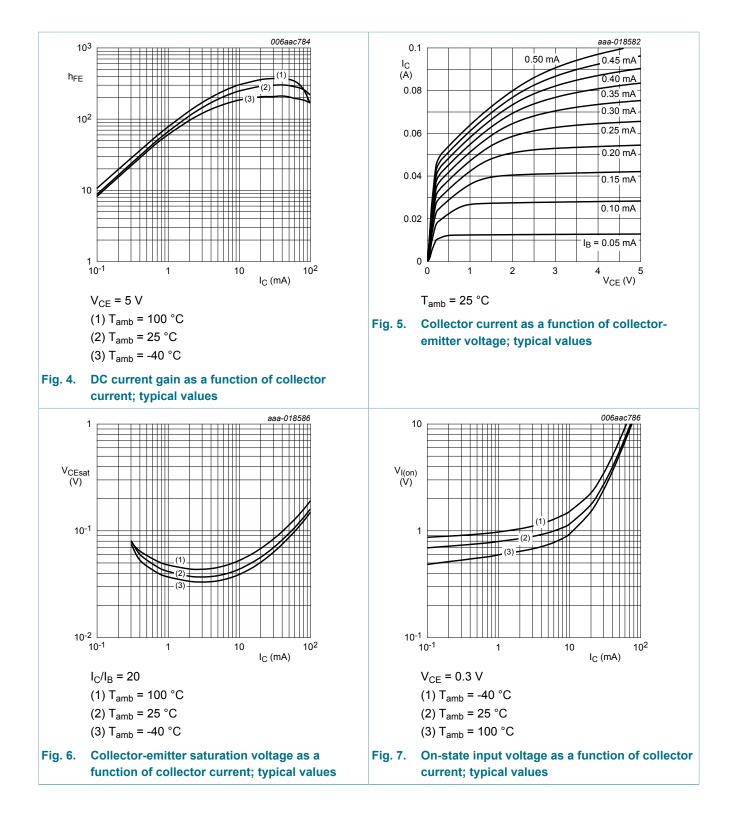
[1] See section "Test information" for resistor calculation and test conditions.

[2] Characteristics of built-in transistor

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NPN/NPN resistor-equipped transistors; R1 = 10 k Ω , R2 = 47 k Ω



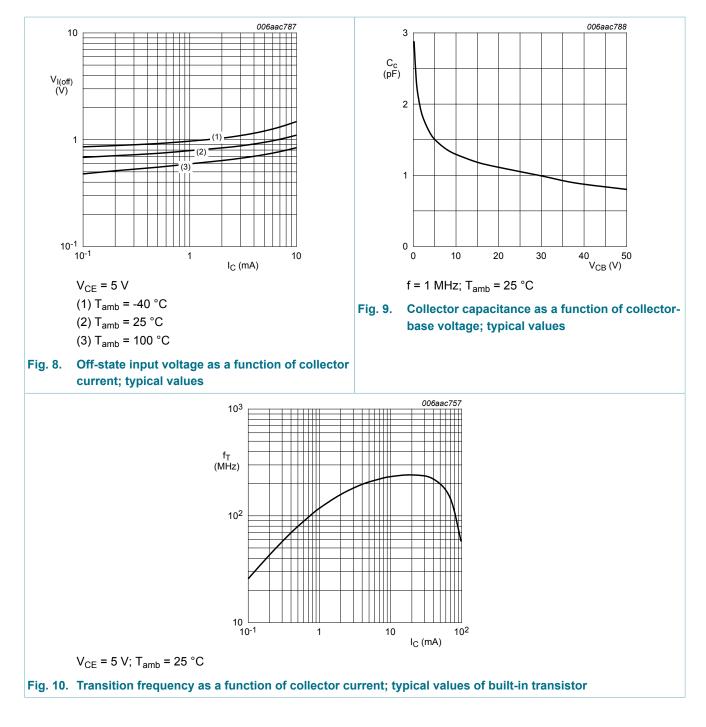
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11. Test information

11.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

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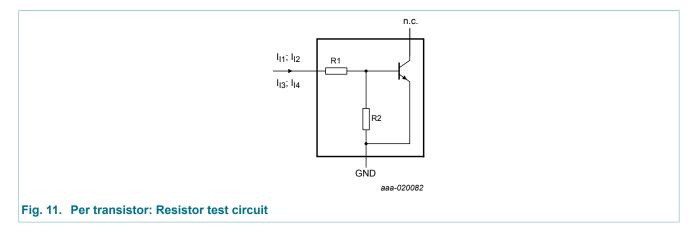
11.2 Resistor calculation

• Calculation of bias resistor 1 (R1)

$$R1 = \frac{V(I_{12}) - V(I_{11})}{I_{12} - I_{11}}$$

• Calculation of bias resistor ratio (R2/R1)

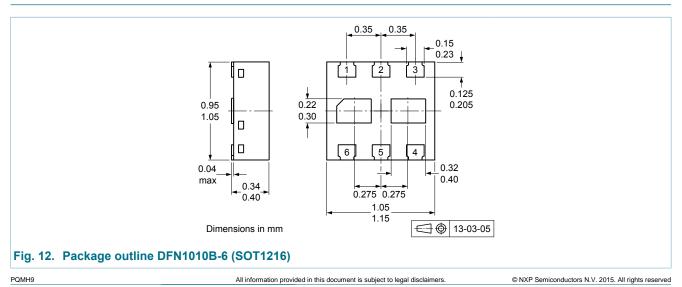
$$\frac{R2}{R1} = \frac{V(I_{14}) - V(I_{13})}{R1 \cdot (I_{14} - I_{13})} - 1$$



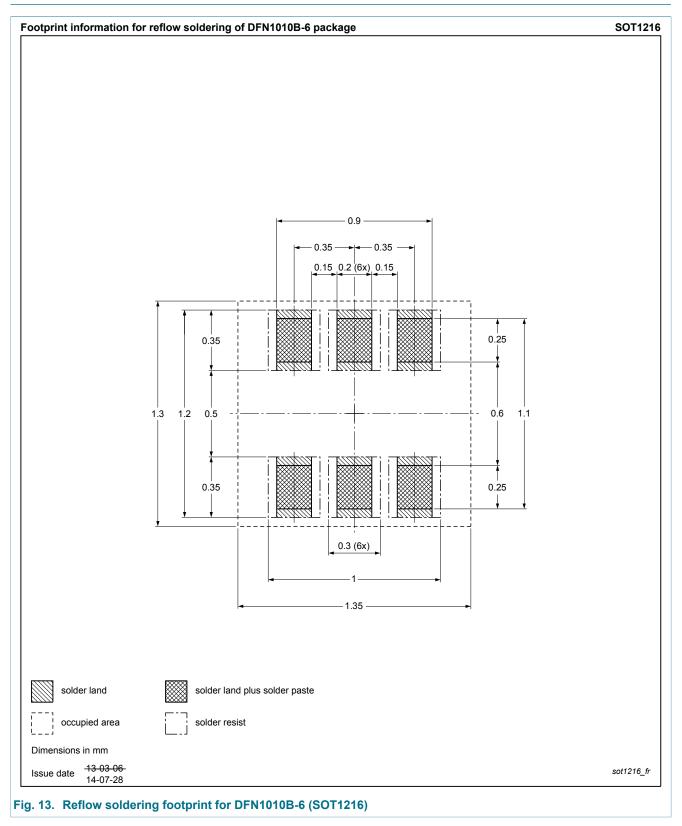
11.3 Resistor test conditions

Table 8.	Resistor test conditions				
R1 (kΩ)	R2 (kΩ)	Test conditions			
		I _{I1}	I _{I2}	I ₁₃	I ₁₄
10	47	90 µA	140 µA	-55 μA	-105 µA

12. Package outline



13. Soldering



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14. Revision history

Table 9. Revision his	ible 9. Revision history					
Data sheet ID	Release date	Data sheet status	Change notice	Supersedes		
PQMH9 v.1	20151104	Product data sheet	-	-		

15. Legal information

15.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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NPN/NPN resistor-equipped transistors; R1 = 10 k Ω , R2 = 47 k Ω

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16. Contents

1	General description1
2	Features and benefits1
3	Applications1
4	Quick reference data 1
5	Pinning information2
6	Ordering information2
7	Marking
8	Limiting values4
9	Thermal characteristics5
10	Characteristics
11	Test information8
11.1	Quality information8
11.2	Resistor calculation9
11.3	Resistor test conditions9
12	Package outline9
13	Soldering10
14	Revision history11
15	Legal information12
15.1	Data sheet status 12
15.2	Definitions12
15.3	Disclaimers12
15.4	Trademarks 13

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